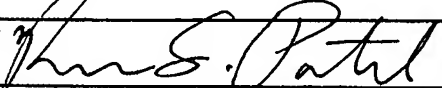


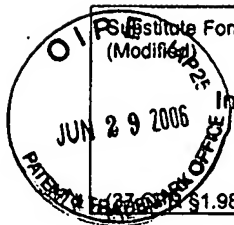
Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 15626-050US1	Application No. 10/561,582
Information Disclosure Statement by Applicant (Use several sheets if necessary)		Applicant Christoph Brabec et al.	
		Filing Date December 19, 2005	Group Art Unit 2812
(37 CFR §1.98(b))			

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
RSP	AA	6933436	23 Aug 2005	Shaheen et al.	—	—	
	AB						
	AC						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
RSP	AD	WO 01/59854	16 Aug 2001	PCT	—	—		
RSP	AE	WO 01/47044	28 June 2001	PCT	—	—		
RSP	AF	WO 01/84645	8 Nov. 2001	PCT	—	—	6933436	
RSP	AG	JP2004 165474	10 June 2004	Japan	—	—	2004/0094196	
	AH						Abstract only	

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
RSP	AI	Shaheen et al., "2.5% efficient organic plastic solar cells", <u>Applied Physics Letters</u> , AIP, American Institute of Physics, Melville, NY, Vol. 78, Number 6, 5 February 2001
RSP	AJ	Brabec et al., "Plastic solar cells", <u>Advanced Functional Materials</u> , 2001, 11, No. 1, February
RSP	AK	Brabec et al., "The influence of materials work function on the open circuit voltage of plastic solar cells", <u>Thin Solid Films</u> , Elsevier Sequoia, NL, Vol. 403-404 (2002), 368-372
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RSP	AN	Manca et al. "State-of-the-art MIDMO-PPV:PCBM bulk hetero-junction organic solar cells: materials, nano-morphology and electro-optical properties", Proceedings of the SPIE "Organic Photovoltaics III", SPIE, Bellingham, VA, Vol. 4801, No. 11, July 2002
RSP	AO	Cravino et al, "Conjugated polymer/fullerene based organic solar cells", Contribution for the Proceedings for the European Meeting on High Efficiency Solar Cells, Ispra, Italy, 15-16 November, 2001.

Examiner Signature 	Date Considered 5/21/07
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	


 Substitute Form PTO-1449
 (Modified)

 U.S. Department of Commerce
 Patent and Trademark Office

 Attorney's Docket No.
 15626-050US1

 Application No.
 10/561,582

**Information Disclosure Statement
 by Applicant**

(Use several sheets if necessary)

 Applicant
 Christoph Brabec et al.

 Filing Date
 December 19, 2005

 Group Art Unit
 2812

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Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
RSP	AA	6,812,399	11/2/2004	Shaheen et al.	—	—	
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Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
RSP	AE	01/84644	11/8/2001	WIPO	—	—		
RSP	AF	01/86734	11/15/2001	WIPO	—	—		
RSP	AG	03/015189	2/20/2003	WIPO	—	—		
RSP	AH	03/098715	11/27/2003	WIPO	—	—		

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
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Examiner Signature

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